



Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-185001	Application No. 10/730,047
	Applicant Shunpei Yamazaki et al.		
	Filing Date December 9, 2003	Group Art Unit 2822	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>JP</i>	AA	6,312,304 B1	11/06/2001	Duthaler et al.			12/14/1999
<i>JP</i>	AB	6,441,474, B2	08/27/2002	Naitoh et al.			04/02/2001
<i>JP</i>	AC	6,883,934 B2	04/26/2005	Kawakami et al.			07/12/2001
<i>JP</i>	AD	2004-0140547	07/22/2004	Yamazaki et al.			12/09/2003
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Foreign Patent Documents or Published Foreign Patent Applications								
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Other Documents (include Author, Title, Date, and Place of Publication)		
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Examiner Signature <i>[Signature]</i>	Date Considered <i>12/27/05</i>
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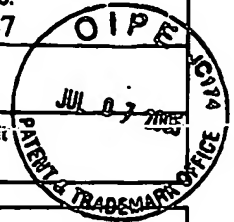
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>JS</i>	AL	JP2002-189447	05 July 2002	JAPAN			Abstract	
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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>LR</i>	AA	2002/0131007 A1	09/19/2002	Yamazaki et al.			05/01/2002
<i>LR</i>	AB	2003/0025118 A1	02/06/2003	Yamazaki et al.			07/22/2002
<i>LR</i>	AC	2003/0032210 A1	02/13/2003	Takayama et al.			07/15/2002
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<i>LR</i>	AT	5,804,872	09/08/1998	Miyano et al.			02/05/1997
<i>LR</i>	AU	5,821,138	10/13/1998	Yamazaki et al.			02/16/1996
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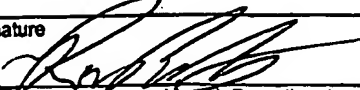
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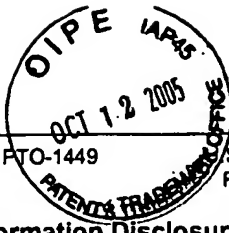
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RD	ACC	10-125930	05/15/1998	JAPAN			AB	
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RD	AII	"Two-way display developed"; Newspaper " <i>The Japan Times</i> "; July 3, 2003
RD	AJJ	<i>Exhibition of Active Matrix Type Organic EL Display at "13th Flat Panel Display Manufacturing Technology Expo & Conference"</i> by ELDis Group; July 2, 2003 (full translation)
RD	AKK	Documents distributed in the " <i>13th Flat Panel Display Manufacturing Technology Expo & Conference</i> " by ELDis Group; July 2, 2003 (full translation)

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(37 CFR §1.98(d))

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